

Application/Control No.	Applicant(s)/Patent under Reexamination
10/774,778	DUDZIAK ET AL.
Examiner	Art Unit
Krishnan S. Menon	1723

	SEARCHED					
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Inventor search; 210/650, 651, 652, 644, 490, 500.25	4/17/2006	KM
updated	8/28/2006	КМ